

## **MOSFET**

Metal Oxide Semiconductor Field Effect Transistor

# **OptiMOS**<sup>™</sup>

OptiMOS<sup>™</sup> Power-MOSFET, 25 V BSB008NE2LX

# **Data Sheet**

Rev. 2.0 Final



## OptiMOS<sup>™</sup> Power-MOSFET, 25 V

### BSB008NE2LX

#### 1 **Description**

### **Features**

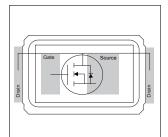
- · Optimized for e-fuse and OR-ing application
- Ultra low Rdson in CanPAK-MX footprint
- Low profile (<0.7 mm)
- 100% avalanche tested
  100% Rg Tested
  Double-sided cooling

- Compatible with DirectFET® package MX footprint and outline <sup>1)</sup>
   Qualified according to JEDEC<sup>2)</sup> for target applications



Table 1 Rey 1 errormance 1 arameters							
Parameter	Value	Unit					
V <sub>DS</sub>	25	V					
R <sub>DS(on),max</sub>	0.8	mΩ					
I <sub>D</sub>	180	A					
Qoss	74	nC					
Q <sub>g</sub> (0V10V)	258	nC					











Type / Ordering Code	Package	Marking	Related Links
BSB008NE2LX	MG-WDSON-2	04E2	-

2 Final Data Sheet Rev. 2.0, 2015-01-20

<sup>&</sup>lt;sup>1)</sup> CanPAK<sup>™</sup> uses DirectFET ® technology licensed from International Rectifier Corporation. DirectFET® is a registered trademark of International Rectifier Corporation.
<sup>2)</sup> J-STD20 and JESD22



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## BSB008NE2LX

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BSB008NE2LX

**2 Maximum ratings** at  $T_j = 25$  °C, unless otherwise specified

Table 2 Maximum ratings

Davamatav	Oh a l		Value	s		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I <sub>D</sub>	- - -	-	180 165 46	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =45 K/W
Pulsed drain current <sup>1)</sup>	I <sub>D,pulse</sub>	-	-	400	Α	<i>T</i> <sub>C</sub> =25 °C
Avalanche current, single pulse <sup>2)</sup>	I <sub>AS</sub>	-	-	40	Α	<i>T</i> <sub>C</sub> =25 °C
Avalanche energy, single pulse	<b>E</b> AS	-	-	600	mJ	$I_D$ =40 A, $R_{GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	89 2.8	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =45 K/W
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-40	-	150	°C	IEC climatic category; DIN IEC 68-1: 40/150/56

#### 3 Thermal characteristics

Table 3 **Thermal characteristics** 

Parameter	Symbol	Values			Unit	Note / Test Condition
Farailleter	Syllibol	Min.	Тур.	Max.	Offic	Note / Test Condition
Thermal resistance, junction - case, bottom	R <sub>thJC</sub>	-	1.0	_	K/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	-	1.4	K/W	-
Device on PCB, 6 cm <sup>2</sup> cooling area <sup>3)</sup>	R <sub>thJA</sub>	-	-	45	K/W	-

See figure 3 for more detailed information
 See figure 13 for more detailed information
 Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm2 (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.



## 4 Electrical characteristics

**Table 4** Static characteristics

Downwater	Cumbal		Values			Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	$V_{(BR)DSS}$	25	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA
Gate threshold voltage	$V_{\rm GS(th)}$	1.2	-	2	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=250\ \mu{\rm A}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.1 10	10 100	μA	V <sub>DS</sub> =25 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =25 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C
Gate-source leakage current	I <sub>GSS</sub>	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.75 0.6	1.0 0.8	mΩ	$V_{GS}$ =4.5 V, $I_{D}$ =25 A $V_{GS}$ =10 V, $I_{D}$ =30 A
Gate resistance	R <sub>G</sub>	0.3	0.5	1.0	Ω	-
Transconductance	<b>g</b> fs	120	240	-	S	$ V_{DS}  > 2 I_D R_{DS(on)max}, I_D = 30 \text{ A}$

 Table 5
 Dynamic characteristics

Doromotor	Symbol		Values			Nata / Tast Canditian
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	12000	16000	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =12 V, <i>f</i> =1 MHz
Output capacitance	Coss	-	3800	5100	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =12 V, f=1 MHz
Reverse transfer capacitance	C <sub>rss</sub>	-	3300	-	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =12 V, f=1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	12.6	_	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	47.2	_	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{ m d(off)}$	-	75	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	32.4	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Table 6 Gate charge characteristics<sup>1)</sup>

Downwoodow	Correspond		Values			Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	$Q_{gs}$	-	27	36	nC	$V_{DD}$ =12 V, $I_{D}$ =30 A, $V_{GS}$ =0 to 4.5 V
Gate charge at threshold	$Q_{g(th)}$	-	19	-	nC	$V_{DD}$ =12 V, $I_{D}$ =30 A, $V_{GS}$ =0 to 4.5 V
Gate to drain charge	$Q_{ m gd}$	-	73	110	nC	$V_{DD}$ =12 V, $I_{D}$ =30 A, $V_{GS}$ =0 to 4.5 V
Switching charge	$Q_{sw}$	-	81	-	nC	$V_{DD}$ =12 V, $I_{D}$ =30 A, $V_{GS}$ =0 to 4.5 V
Gate charge total	$Q_{g}$	-	146	194	nC	$V_{DD}$ =12 V, $I_{D}$ =30 A, $V_{GS}$ =0 to 4.5 V
Gate plateau voltage	$V_{ m plateau}$	-	2.2	-	V	$V_{DD}$ =12 V, $I_{D}$ =30 A, $V_{GS}$ =0 to 4.5 V
Gate charge total	$Q_g$	-	258	343	nC	$V_{DD}$ =12 V, $I_{D}$ =30 A, $V_{GS}$ =0 to 10 V
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	88	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 4.5 V
Output charge	Qoss	-	74	98	nC	V <sub>DD</sub> =12 V, V <sub>GS</sub> =0 V

<sup>1)</sup> See "Gate charge waveforms" for parameter definition



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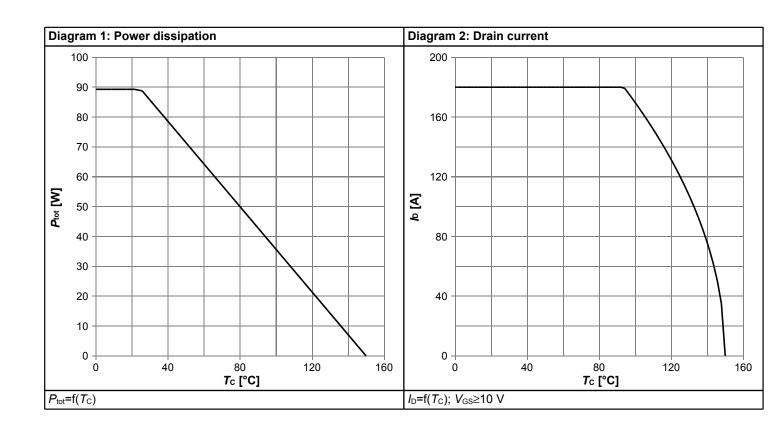
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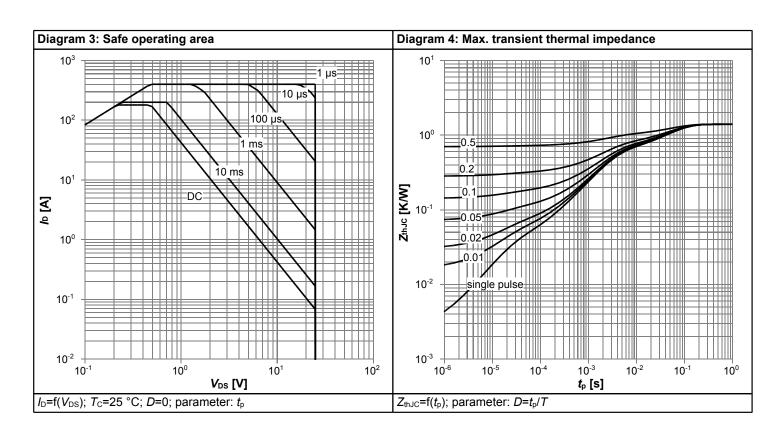
### Table 7 Reverse diode

Doromotor	Cumbal	Values			11:4	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	89	Α	<i>T</i> <sub>C</sub> =25 °C
Diode pulse current	I <sub>S,pulse</sub>	-	-	400	Α	<i>T</i> <sub>C</sub> =25 °C
Diode forward voltage	<b>V</b> <sub>SD</sub>	-	0.78	-	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =30 A, T <sub>j</sub> =25 °C
Reverse recovery charge	Qrr	-	20	-	nC	V <sub>R</sub> =15 V, I <sub>F</sub> =I <sub>S</sub> , di <sub>F</sub> /dt=400 A/μs

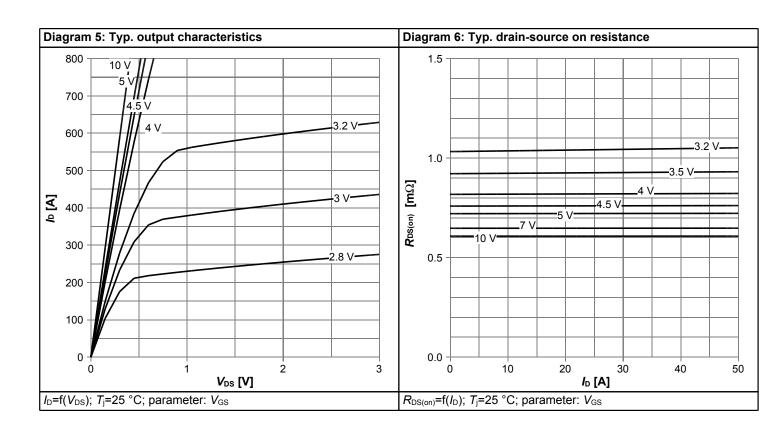


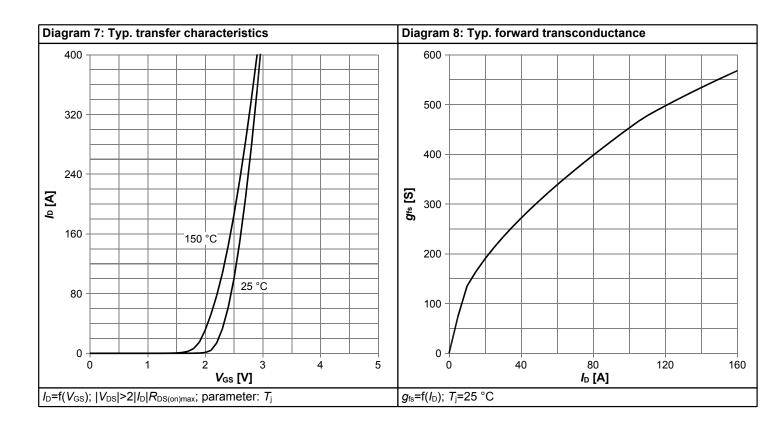
## 5 Electrical characteristics diagrams



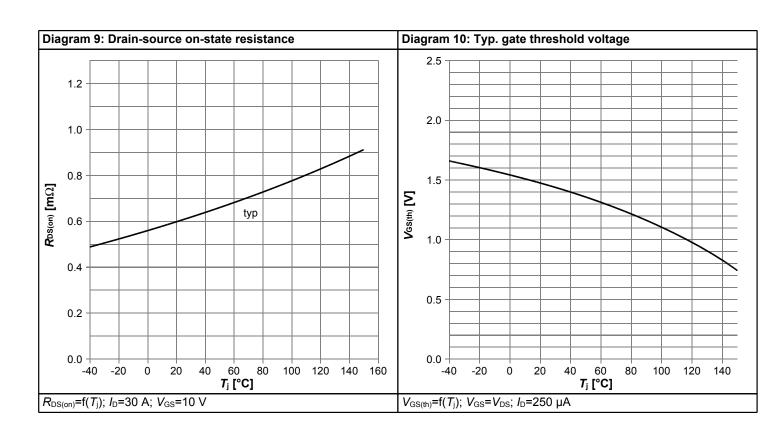


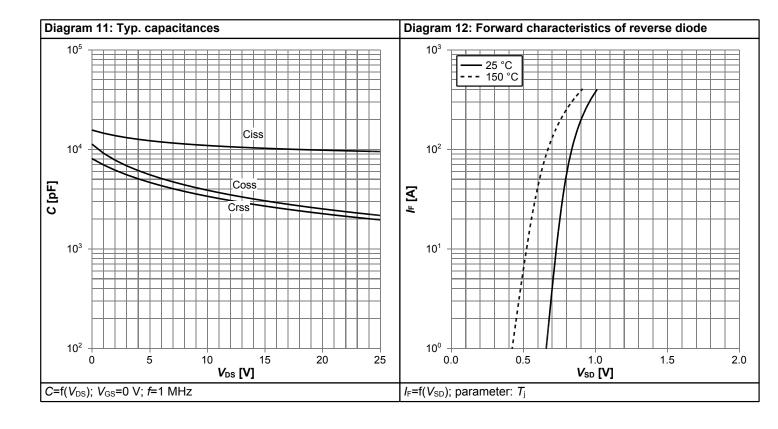




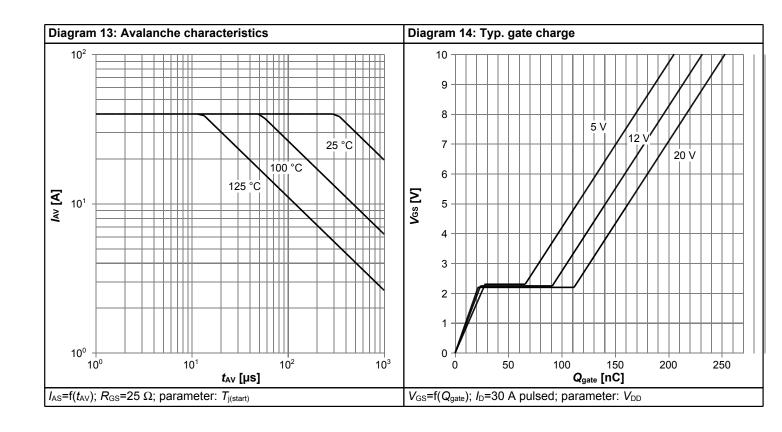


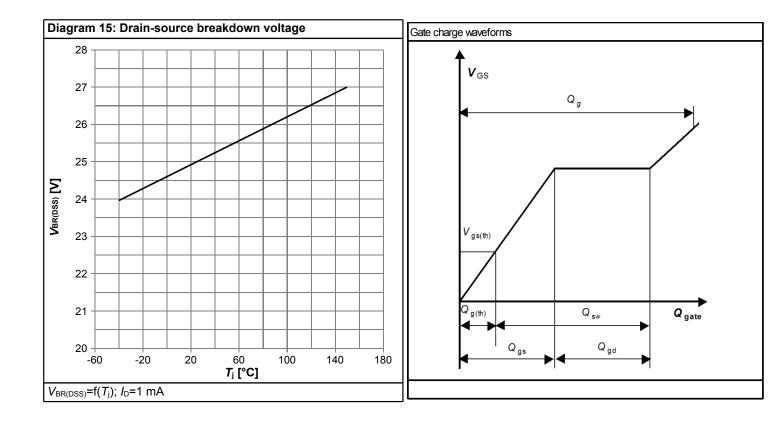














## 6 Package Outlines

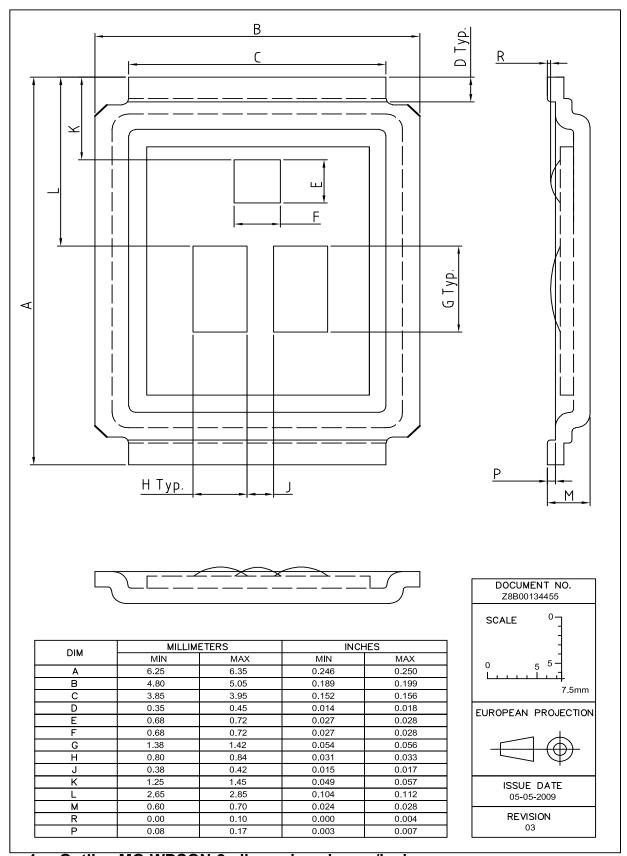


Figure 1 Outline MG-WDSON-2, dimensions in mm/inches



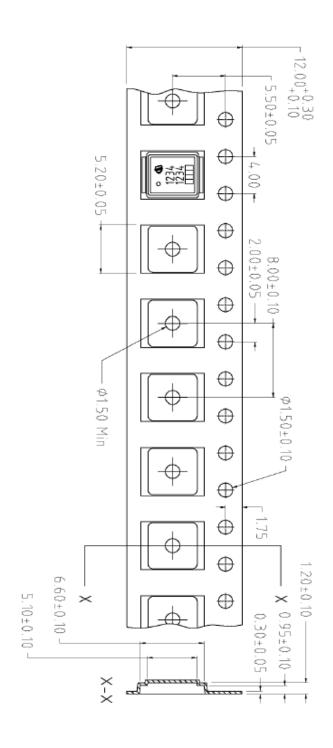


Figure 2 Outline Tape CanPAK MX, dimensions in mm



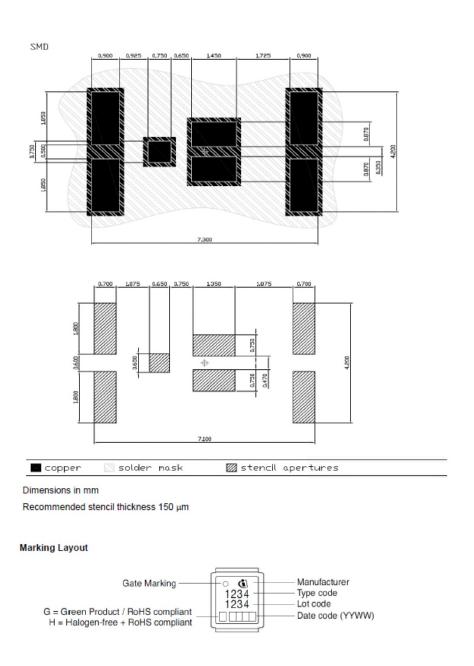


Figure 3 Outline Boardpads and apertures CanPAK MX, dimensions in mm

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## OptiMOS™ Power-MOSFET, 25 V

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### **Revision History**

BSB008NE2LX

Revision: 2015-01-20, Rev. 2.0

**Previous Revision** 

Revision	Date	Subjects (major changes since last revision)
2.0	2015-01-20	Release of final version

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